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## Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

## Applications of Embedded - CPLDs

### Details

Product Status	Obsolete
Programmable Type	In System Programmable
Delay Time tpd(1) Max	12 ns
Voltage Supply - Internal	3V ~ 3.6V
Number of Logic Elements/Blocks	-
Number of Macrocells	512
Number of Gates	-
Number of I/O	120
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	160-BQFP
Supplier Device Package	160-PQFP (28x28)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/lattice-semiconductor/m5lv-512-120-12yc">https://www.e-xfl.com/product-detail/lattice-semiconductor/m5lv-512-120-12yc</a>

**Select devices have been discontinued.  
See Ordering Information section for product status.**

**Table 1. MACH 5 Device Features<sup>1</sup>**

Feature	M5-128/1 M5LV-128		M5-192/1		M5-256/1 M5LV-256		M5-320 M5LV-320		M5-384 M5LV-384		M5-512 M5LV-512	
Supply Voltage (V)	5	3.3	5	5	3.3	5	3.3	5	3.3	5	3.3	
Macrocells	128	128	192	256	256	320	320	384	384	512	512	
Maximum User I/O Pins	120	120	120	160	160	192	160	160	160	256	256	
t <sub>PD</sub> (ns)	5.5	5.5	5.5	5.5	5.5	6.5	6.5	6.5	6.5	6.5	6.5	
t <sub>SS</sub> (ns)	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	3.0	
t <sub>COS</sub> (ns)	4.5	4.5	4.5	4.5	4.5	5.0	5.0	5.0	5.0	5.0	5.0	
f <sub>CNT</sub> (MHz)	182	182	182	182	182	167	167	167	167	167	167	
Typical Static Power (mA)	35	35	45	55	55	70	70	75	75	100	100	
IEEE 1149.1 Boundary Scan Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	
PCI-Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	

**Note:**

1. "M5-xxxx" is for 5-V devices. "M5LV-xxxx" is for 3.3-V devices.

## GENERAL DESCRIPTION

The MACH® 5 family consists of a broad range of high-density and high-I/O Complex Programmable Logic Devices (CPLDs). The fifth-generation MACH architecture yields fast speeds at high CPLD densities, low power, and supports additional features such as in-system programmability, Boundary Scan testability, and advanced clocking options (Table 1). The MACH 5 family offers 5-V (M5-xxx) and 3.3-V (M5LV-xxx) operation.

Manufactured in state-of-the-art ISO 9000 qualified fabrication facilities on E<sup>2</sup>CMOS process technologies, MACH 5 devices are available with pin-to-pin delays as fast as 5.5 ns (Table 2). The 5.5, 6.5, 7.5, 10, and 12-ns devices are compliant with the *PCI Local Bus Specification*.

**Table 2. MACH 5 Speed Grades**

Device	Speed Grade <sup>1</sup>						
	-5	-6	-7	-10	-12	-15	-20
M5-128 <sup>2</sup>			C	C, I	C, I	C, I	I
M5-128/1	C		C, I	C, I	C, I	C, I	I
M5LV-128	C		C,I	C, I	C, I	I	
M5-192/1	C		C, I	C, I	C, I	C, I	I
M5-256 <sup>2</sup>			C	C, I	C, I	C, I	I
M5-256/1	C		C, I	C, I	C, I	C, I	I
M5LV-256	C		C, I	C, I	C, I	I	
M5-320		C	C, I	C, I	C, I	C, I	I
M5LV-320		C	C, I	C, I	C, I	C, I	I
M5-384		C	C, I	C, I	C, I	C, I	I
M5LV-384		C	C, I	C, I	C, I	C, I	I
M5-512		C	C, I	C, I	C, I	C, I	I
M5LV-512		C	C, I	C, I	C, I	C, I	I

**Note:**

1. C = Commercial grade, I = Industrial grade
2. /1 version recommended for new designs

With Lattice's unique hierarchical architecture, the MACH 5 family provides densities up to 512 macrocells to support full system logic integration. Extensive routing resources ensure pinout retention as well as high utilization. It is ideal for PAL® block device integration and a wide range of other applications including high-speed computing, low-power applications, communications, and embedded control. At each macrocell density point, Lattice offers several I/O and package options to meet a wide range of design needs (Table 3).

**Table 3. MACH 5 Package and I/O Options<sup>1</sup>**

Supply Voltage	M5-128/1 M5LV-128		M5-256/1 M5LV-256		M5-320 M5LV-320		M5-384 M5LV-384		M5-512 M5LV-512		
	5	3.3	5	5	3.3	5	3.3	5	3.3	5	3.3
100-pin TQFP	68	68, 74	68	68	68*, 74						
100-pin PQFP	68	68*	68*	68*	68						
144-pin TQFP		104			104						
144-pin PQFP	104	104*	104*	104*	104*						
160-pin PQFP	120	120	120	120	120	120*	120	120*	120	120*	120
208-pin PQFP				160	160	160	160	160	160	160	160
240-pin PQFP						184*	184*	184*	184*	184*	184*
256-ball BGA						192	192*	192*	192*	192*	192*
352-ball BGA										256	256

**Note:**

1. The I/O options indicated with a "\*" are obsolete, please contact factory for more information.

Advanced power management options allow designers to incrementally reduce power while maintaining the level of performance needed for today's complex designs. I/O safety features allow for mixed-voltage design,

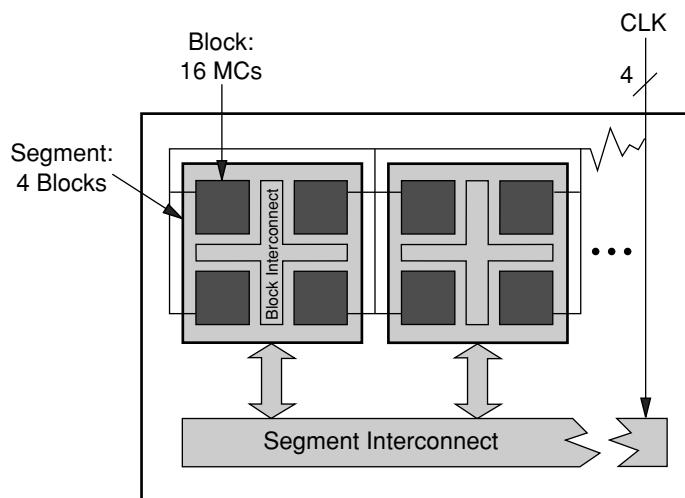
**Select devices have been discontinued.  
See Ordering Information section for product status.**

Select devices have been discontinued.  
See Ordering Information section for product status.

and both the 3.3-V and the 5-V device versions are in-system programmable through an IEEE 1149.1 Test Access Port (TAP) interface.

## FUNCTIONAL DESCRIPTION

The MACH 5 architecture consists of PAL blocks connected by two levels of interconnect. The **block interconnect** provides routing among 4 PAL blocks. This grouping of PAL blocks joined by the block interconnect is called a **segment**. The second level of interconnect, the **segment interconnect**, ties all of the segments together. The only logic difference between any two MACH 5 devices is the number of segments. Therefore, once a designer is familiar with one device, consistent performance can be expected across the entire family. All devices have four clock pins available which can also be used as logic inputs.



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Figure 1. MACH 5 Block Diagram

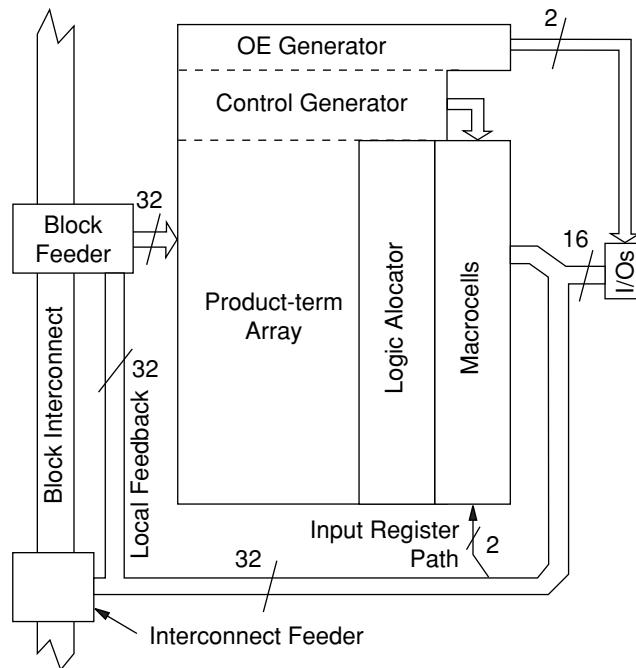
The MACH 5 PAL blocks consist of the elements listed below (Figure 2). While each PAL block resembles an independent PAL device, it has superior control and logic generation capabilities.

- ◆ I/O cells
- ◆ Product-term array and Logic Allocator
- ◆ Macrocells
- ◆ Register control generator
- ◆ Output enable generator

### I/O Cells

The I/Os associated with each PAL block have a path directly back to that PAL block called **local feedback**. If the I/O is used in another PAL block, the **interconnect feeder** assigns a **block interconnect** line to that signal. The interconnect feeder acts as an input switch matrix. The block and segment interconnects provide connections between any two signals in a device. The **block feeder** assigns block interconnect lines and local feedback lines to the PAL block inputs.

Select devices have been discontinued.  
See Ordering Information section for product status.



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**Figure 2. PAL Block Structure**

## Product-Term Array and Logic Allocator

The product-term array uses the same sum-of-products architecture as PAL devices and consists of 32 inputs (plus their complements) and 64 product terms arranged in 16 **clusters**. A cluster is a sum-of-products function with either 3 or 4 product terms.

**Logic allocators** assign the clusters to macrocells. Each macrocell can accept up to eight clusters of three or four product terms, but a given cluster can only be steered to one macrocell (Table 4). If only three product terms in a cluster are steered, the fourth can be used as an input to an XOR gate for separate logic generation and/or polarity control.

The **wide logic allocator** is comprised of all 16 of the individual logic allocators and acts as an output switch matrix by reassigning logic to macrocells to retain pinout as designs change. The logic allocation scheme in the MACH 5 device allows for the implementation of large equations (up to 32 product terms) with only one pass through the logic array.

**Table 4. Product Term Steering Options for PT Clusters and Macrocells**

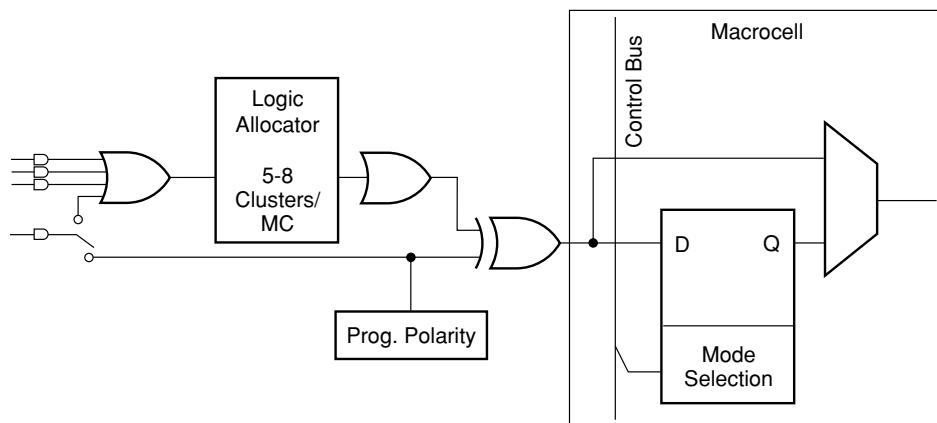
Macrocell	Available Clusters	Macrocell	Available Clusters
M <sub>0</sub>	C <sub>0</sub> , C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub>	M <sub>8</sub>	C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub> , C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub>
M <sub>1</sub>	C <sub>0</sub> , C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub>	M <sub>9</sub>	C <sub>6</sub> , C <sub>7</sub> , C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub>
M <sub>2</sub>	C <sub>0</sub> , C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub>	M <sub>10</sub>	C <sub>7</sub> , C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub>
M <sub>3</sub>	C <sub>0</sub> , C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub>	M <sub>11</sub>	C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub> , C <sub>15</sub>
M <sub>4</sub>	C <sub>0</sub> , C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub>	M <sub>12</sub>	C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub> , C <sub>15</sub>
M <sub>5</sub>	C <sub>1</sub> , C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub> , C <sub>8</sub>	M <sub>13</sub>	C <sub>9</sub> , C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub> , C <sub>15</sub>
M <sub>6</sub>	C <sub>2</sub> , C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub> , C <sub>8</sub> , C <sub>9</sub>	M <sub>14</sub>	C <sub>10</sub> , C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub> , C <sub>15</sub>
M <sub>7</sub>	C <sub>3</sub> , C <sub>4</sub> , C <sub>5</sub> , C <sub>6</sub> , C <sub>7</sub> , C <sub>8</sub> , C <sub>9</sub> , C <sub>10</sub>	M <sub>15</sub>	C <sub>11</sub> , C <sub>12</sub> , C <sub>13</sub> , C <sub>14</sub> , C <sub>15</sub>

## Macrocells

The macrocells for MACH 5 devices consist of a storage element which can be configured for combinatorial, registered or latched operation (Figure 3). The D-type flip-flops can be configured as T-type, J-K, or S-R operation through the use of the XOR gate associated with each macrocell.

Each PAL block has the capability to provide two input registers by using macrocells 0 and 15. In order to use this option, these macrocells must be accessed via the I/O pins associated with macrocells 3 and 12, respectively. Once the macrocell is used as an input register, it cannot be used for logic, so its clusters can be re-directed through the logic allocator to another macrocell. The

I/O pins associated with macrocells 0 and 15 can still be used as input pins. Although the I/O pins for macrocells 3 and 12 are used to connect to the input registers, these macrocells can still be used as “buried” macrocells to drive device logic via the matrix.



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**Figure 3. Macrocell Diagram**

## Control Generator

The control generator provides four configurable clock lines and three configurable set/reset lines to each macrocell in a PAL block. Any of the four clock lines and any of the three set/reset lines can be independently selected by any flip-flop within a block. The clock lines can be configured to provide synchronous global (pin) clocks and asynchronous product term clocks, sum term clocks, and latch enables (Figure 4). Three of the four global clocks, as well as two product-term clocks and one sum-term clock, are available per PAL block. Positive or negative edge clocking is available as well as advanced clocking features such as **complementary** and **biphase** clocking. Complementary clocking provides two clock lines exactly 180 degrees out of phase, and is useful in applications such as fast data paths. A biphase clock line clocks flip-flops on both the positive and negative edges of the clock. The configuration options for the four clock lines per PAL block are as follows:

### Clock Line 0 Options

- ◆ Global clock (0, 1, 2, or 3) with positive or negative edge clock enable
- ◆ Product-term clock ( $A^*B^*C$ )
- ◆ Sum-term clock ( $A+B+C$ )

### Clock Line 1 Options

- ◆ Global clock (0, 1, 2, or 3) with positive edge clock enable
- ◆ Global clock (0, 1, 2, or 3) with negative edge clock enable

**See Ordering Information section for product status.**

Select devices have been discontinued.

## MULTIPLE I/O AND DENSITY OPTIONS

The MACH 5 family offers six macrocell densities in a number of I/O options. This allows designers to choose a device close to their logic density and I/O requirements, thus minimizing costs. For the same package type, every density has the same pin-out. With proper design considerations, a design can be moved to a higher or lower density part as required.

## IEEE 1149.1 - COMPLIANT BOUNDARY SCAN TESTABILITY

Most MACH 5 devices have boundary scan registers and are compliant to the IEEE 1149.1 standard. This allows functional testing of the circuit board on which the device is mounted through a serial scan path that can access all critical logic nodes. Internal registers are linked internally, allowing test data to be shifted in and loaded directly onto test nodes, or test node data to be captured and shifted out for verification. In addition, these devices can be linked into a board-level serial scan path for more complete board-level testing.

## IEEE 1149.1 - COMPLIANT IN-SYSTEM PROGRAMMING

Programming devices in-system provides a number of significant benefits including: rapid prototyping, lower inventory levels, higher quality, and the ability to make in-field modifications. All MACH 5 devices provide in-system programming (ISP) capability through their IEEE 1149.1-compliant Boundary Scan Test Access Port. By using the IEEE 1149.1-compliant Boundary Scan Test Access Port as the communication interface through which ISP is achieved, customers get the benefit of a standard, well-defined interface.

MACH 5 devices can be programmed across the commercial temperature and voltage range. The PC-based LatticePRO software facilitates in-system programming of MACH 5 devices. LatticePRO software takes the JEDEC file output produced by design implementation software, along with information about the Boundary Scan chain, and creates a set of vectors that are used to drive the Boundary Scan chain. LatticePRO software can use these vectors to drive a Boundary Scan chain via the parallel port of a PC. Alternatively, LatticePRO software can output files in formats understood by common automated test equipment. This equipment can then be used to program MACH 5 devices during the testing of a circuit board.

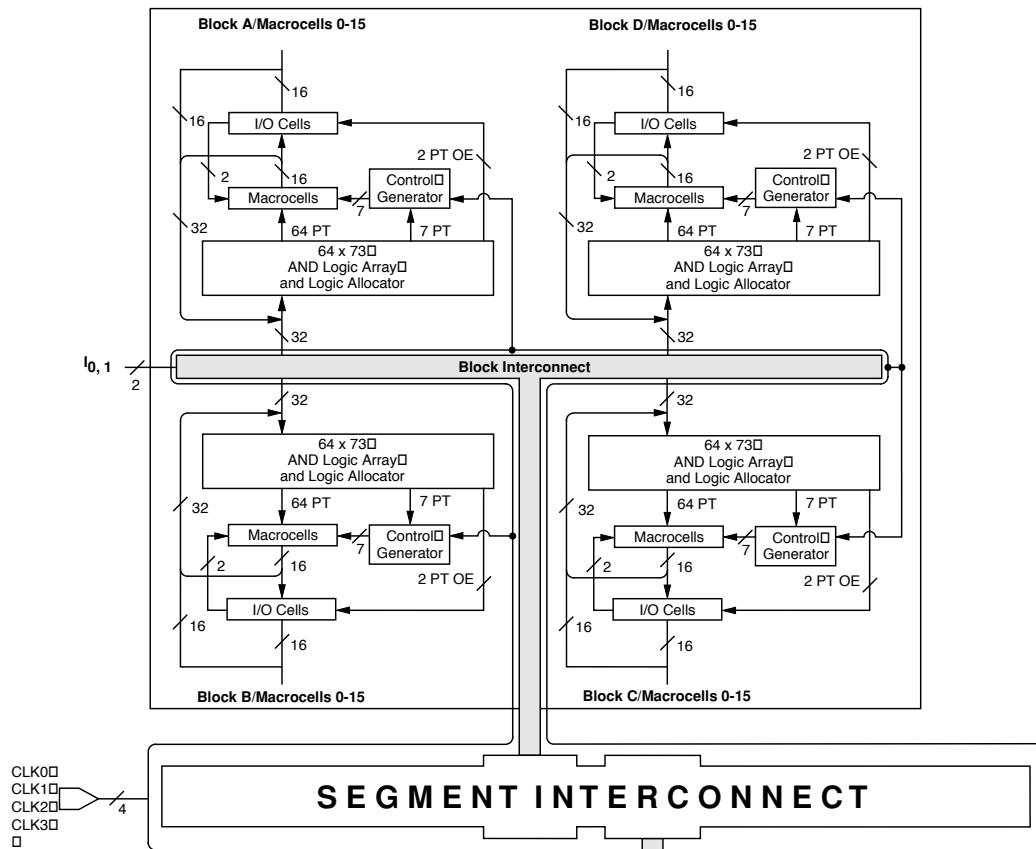
## PCI COMPLIANT

MACH 5 devices in the -5/-6/-7/-10/-12 speed grades are compliant with the *PCI Local Bus Specification* version 2.1, published by the PCI Special Interest Group (SIG). The 5-V devices are fully PCI-compliant. The 3.3-V devices are mostly compliant but do not meet the PCI condition to clamp the inputs as they rise above  $V_{CC}$  because of their 5-V input tolerant feature. MACH 5 devices provide the speed, drive, density, output enables and I/Os for the most complex PCI designs.

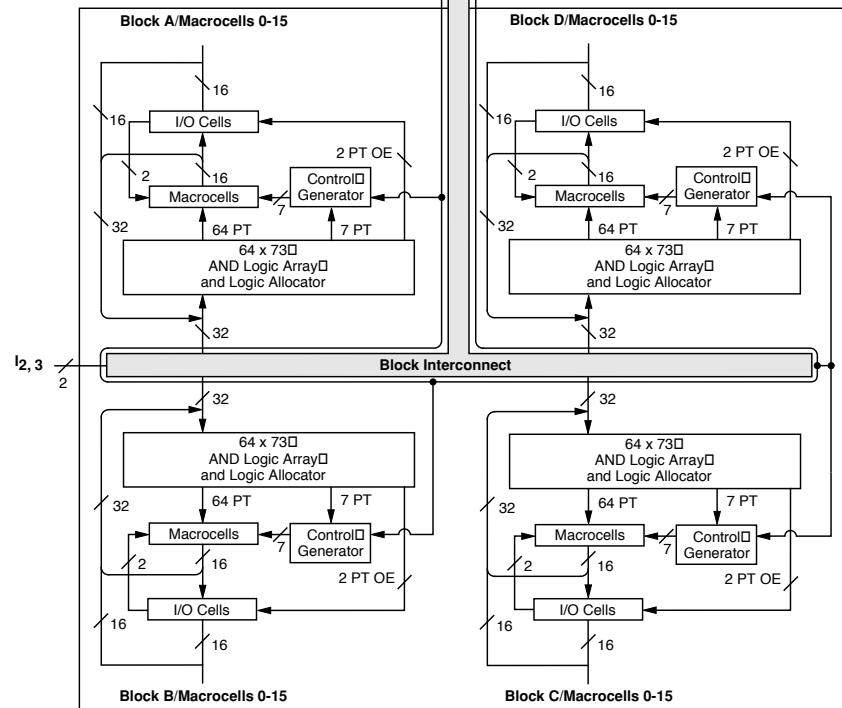
Select devices have been discontinued.  
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## BLOCK DIAGRAM — M5(LV)-128/XXX

### SEGMENT 0



### SEGMENT INTERCONNECT

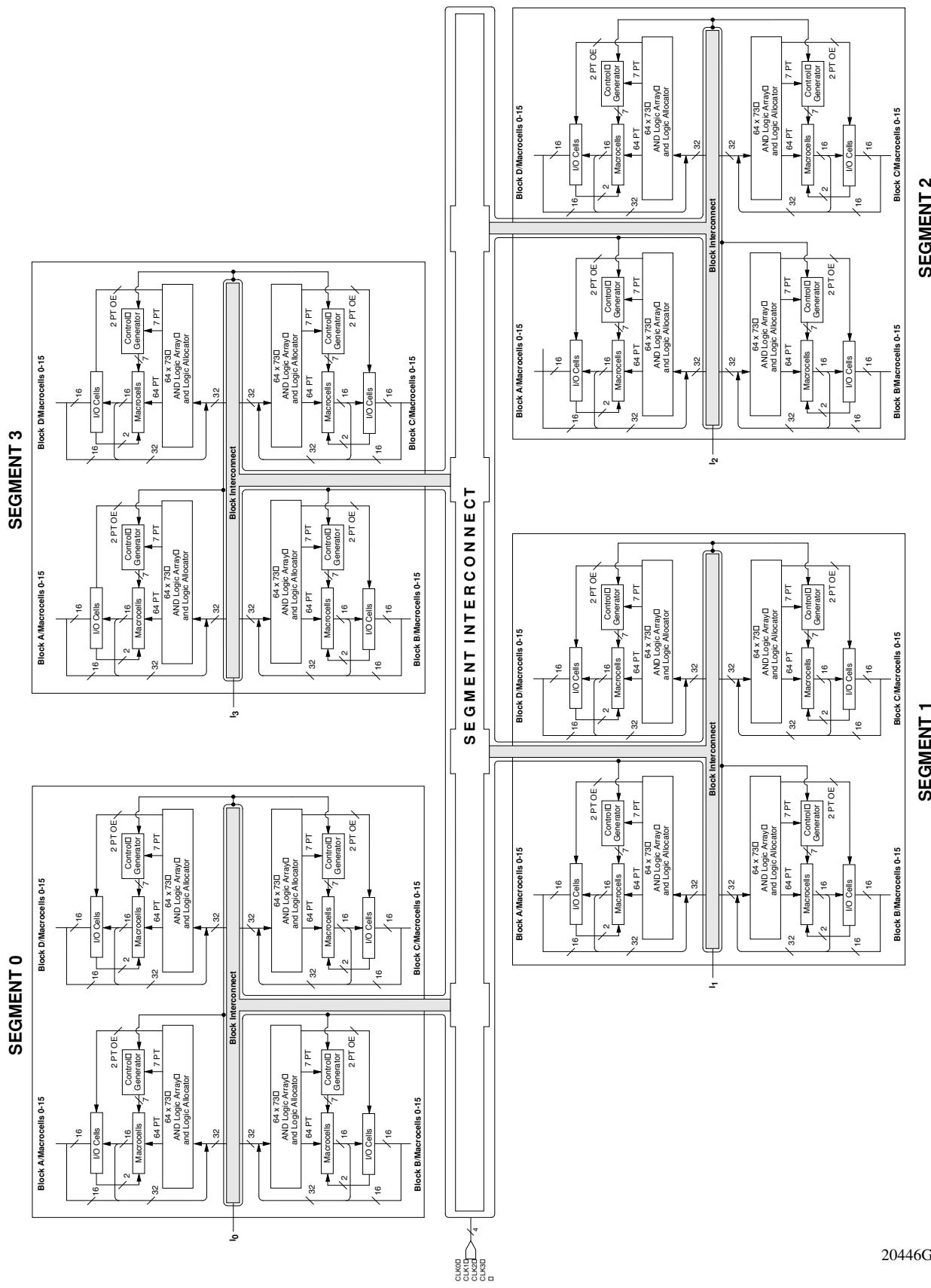


### SEGMENT 1

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**Select devices have been discontinued.**  
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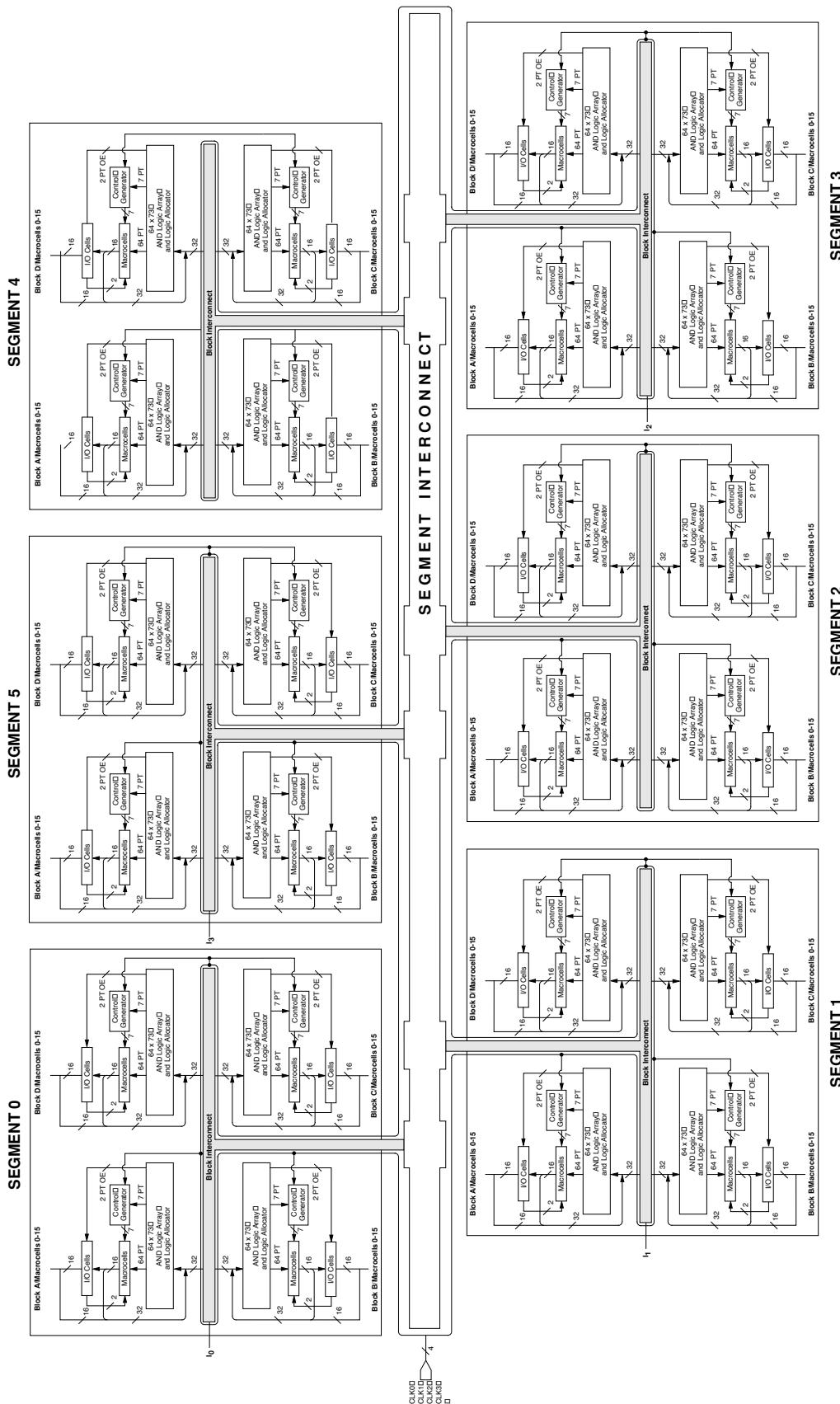
## BLOCK DIAGRAM — M5(LV)-256/XXX



20446G-009

**Select devices have been discontinued.**  
**See Ordering Information section for product status.**

## BLOCK DIAGRAM — M5(LV)-384/XXX



20446G-011

Select devices have been discontinued.  
See Ordering Information section for product status.

## ABSOLUTE MAXIMUM RATINGS

### M5

Storage Temperature.....	-65°C to +150°C
Device Junction Temperature (Note 1).....	+130°C or +150°C
Supply Voltage with Respect to Ground .....	-0.5 V to +7.0 V
DC Input Voltage .....	-0.5 V to 5.5 V
Static Discharge Voltage.....	2000 V
Latchup Current (-40°C to +85°C) .....	200 mA
<i>Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.</i>	

## OPERATING RANGES

### Commercial (C) Devices

Ambient Temperature ( $T_A$ )	
Operating in Free Air.....	0°C to +70°C
Supply Voltage ( $V_{CC}$ ) with Respect to Ground.....	+4.75 V to +5.25 V

### Industrial (I) Devices

Ambient Temperature ( $T_A$ )	
Operating in Free Air.....	-40°C to +85°C
Supply Voltage ( $V_{CC}$ ) with Respect to Ground.....	+4.5 V to +5.5 V
<i>Operating ranges define those limits between which the functionality of the device is guaranteed.</i>	

## 5-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Description	Min	Typ	Max	Unit
$V_{OH}$	Output HIGH Voltage (For M5-128/1, M5-192/1, M5-256/1, M5-320, M5-384, M5-512 Devices)	$I_{OH} = -3.2 \text{ mA}, V_{CC} = \text{Min}, V_{IN} = V_{IH} \text{ or } V_{IL}$	2.4			V
		$I_{OH} = -100 \mu\text{A}, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL}$		3.3	3.6	V
	Output HIGH Voltage (For M5-128, M5-192, M5-256 Devices)	$I_{OH} = -3.2 \text{ mA}, V_{CC} = \text{Min}, V_{IN} = V_{IH} \text{ or } V_{IL}$	2.4			V
		$I_{OH} = -2.5 \text{ mA}, V_{CC} = 5.25 \text{ V}, V_{IN} = V_{IH} \text{ or } V_{IL}$			3.6	V
$V_{OL}$	Output LOW Voltage (Note 2)	$I_{OL} = +16 \text{ mA}, V_{CC} = \text{Min}, V_{IN} = V_{IH} \text{ or } V_{IL}$			0.5	V
$V_{IH}$	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for all Inputs (Note 3)	2.0			V
$V_{IL}$	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for all Inputs (Note 3)			0.8	V
$I_{IH}$	Input HIGH Leakage Current	$V_{IN} = 5.25, V_{CC} = \text{Max}$ (Note 4)			10	$\mu\text{A}$
$I_{IL}$	Input LOW Leakage Current	$V_{IN} = 0, V_{CC} = \text{Max}$ (Note 4)			-10	$\mu\text{A}$
$I_{OZH}$	Off-State Output Leakage Current HIGH	$V_{OUT} = 5.25, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 4)			10	$\mu\text{A}$
$I_{OZL}$	Off-State Output Leakage Current LOW	$V_{OUT} = 0, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 4)			-10	$\mu\text{A}$
$I_{SC}$	Output Short-Circuit Current	$V_{OUT} = 0.5 \text{ V}, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL}$ (Note 5)	-30		-180	mA

#### Note:

- 150° for M5-128, M5-192 and M5-256 devices. 130° for M5-128/1, M5-192/1, M5-256/1, M5-320, M5-384 and M5-512 devices.
- Total  $I_{OL}$  between ground pins should not exceed 64 mA.
- These are absolute values with respect to device ground, and all overshoots due to system and/or tester noise are included.
- I/O pin leakage is the worst case of  $I_{IL}$  and  $I_{OZL}$  or  $I_{IH}$  and  $I_{OZH}$ .
- Not more than one output should be shorted at a time. Duration of the short-circuit should not exceed one second.

**Select devices have been discontinued.**  
**See Ordering Information section for product status.**

## ABSOLUTE MAXIMUM RATINGS

### M5LV

Storage Temperature.....	-65°C to +150°C
Device Junction Temperature.....	+130°C
Supply Voltage with Respect to Ground .....	-0.5 V to +4.5 V
DC Input Voltage .....	-0.5 V to 5.5 V
Static Discharge Voltage.....	2000 V
Latchup Current (-40°C to +85°C) .....	200 mA

*Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.*

## OPERATING RANGES

### Commercial (C) Devices

Ambient Temperature ( $T_A$ )	
Operating in Free Air.....	0°C to +70°C
Supply Voltage ( $V_{CC}$ ) with Respect to Ground.....	+3.0 V to +3.6 V

### Industrial (I) Devices

Ambient Temperature ( $T_A$ )	
Operating in Free Air.....	-40°C to +85°C
Supply Voltage ( $V_{CC}$ ) with Respect to Ground.....	+3.0 V to +3.6 V
<i>Operating ranges define those limits between which the functionality of the device is guaranteed.</i>	

## 3.3-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Description		Min	Max	Unit
$V_{OH}$	Output HIGH Voltage	$V_{CC} = \text{Min}$	$I_{OH} = -100 \mu\text{A}$	$V_{CC} = -0.2$		V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = 3.2 \text{ mA}$	2.4		V
$V_{OL}$	Output LOW Voltage	$V_{CC} = \text{Min}$	$I_{OL} = 100 \mu\text{A}$		0.2	V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 16 \text{ mA } (\text{Note 1})$		0.5	V
$V_{IH}$	Input HIGH Voltage	$V_{OUT} \geq V_{OH} \text{ Min or } V_{OUT} \leq V_{OL} \text{ Max } (\text{Note 2})$		2.0	5.5	V
$V_{IL}$	Input LOW Voltage	$V_{OUT} \geq V_{OH} \text{ Min or } V_{OUT} \leq V_{OL} \text{ Max } (\text{Note 2})$		-0.3	0.8	V
$I_{IH}$	Input HIGH Leakage Current	$V_{IN} = 3.6, V_{CC} = \text{Max } (\text{Note 3})$			10	$\mu\text{A}$
$I_{IL}$	Input LOW Leakage Current	$V_{IN} = 0, V_{CC} = \text{Max } (\text{Note 3})$			-10	$\mu\text{A}$
$I_{OZH}$	Off-State Output Leakage Current HIGH	$V_{OUT} = 3.6, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 3)}$			10	$\mu\text{A}$
$I_{OZL}$	Off-State Output Leakage Current LOW	$V_{OUT} = 0, V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 3)}$			-10	$\mu\text{A}$
$I_{SC}$	Output Short-Circuit Current	$V_{OUT} = 0.5 V_{CC} = \text{Max}, V_{IN} = V_{IH} \text{ or } V_{IL} \text{ (Note 4)}$		-15	-160	mA

#### Notes:

1. Total  $I_{OL}$  between ground pins should not exceed 64 mA.
2. These are absolute values with respect to device ground, and all overshoots due to system and/or tester noise are included.
3. I/O pin leakage is the worst case of  $I_{IL}$  and  $I_{OZL}$  or  $I_{IH}$  and  $I_{OZH}$ .
4. Not more than one output should be shorted at one time. Duration of the short-circuit should not exceed one second.

Select devices have been discontinued.  
See Ordering Information section for product status.

## M5(LV) TIMING PARAMETERS OVER OPERATING RANGES<sup>1</sup>

	-5		-6		-7		-10		-12		-15		-20		Unit	
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
<b>Combinatorial Delay:</b>																
t <sub>PDI</sub>	Internal combinatorial propagation delay		3.5		4.5		5.5		8.0		10.0		13.0		18.0	ns
t <sub>PD</sub>	Combinatorial propagation delay		5.5		6.5		7.5		10.0		12.0		15.0		20.0	ns
<b>Registered Delays:</b>																
t <sub>SS</sub>	Synchronous clock setup time	3.0		3.0		4.0		5.0		6.0		8.0		10.0		ns
t <sub>SA</sub>	Asynchronous clock setup time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>HS</sub>	Synchronous clock hold time	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t <sub>HA</sub>	Asynchronous clock hold time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>COSI</sub>	Synchronous clock to internal output		2.5		3.0		4.0		5.0		6.0		8.0		10.0	ns
t <sub>COS</sub>	Synchronous clock to output		4.5		5.0		6.0		7.0		8.0		10.0		12.0	ns
t <sub>COAi</sub>	Asynchronous clock to internal output		6.0		6.0		8.0		10.0		13.0		15.0		18.0	ns
t <sub>COA</sub>	Asynchronous clock to output		8.0		8.0		10.0		12.0		15.0		17.0		20.0	ns
<b>Latched Delays:</b>																
t <sub>SAL</sub>	Latch setup time	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>HAL</sub>	Latch hold time	3.0		3.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>PDLi</sub>	Transparent latch internal		6.0		7.0		7.0		8.0		9.0		10.0		10.0	ns
t <sub>PDL</sub>	Propagation delay through transparent latch		8.0		9.0		9.0		10.0		11.0		12.0		12.0	ns
t <sub>GOAi</sub>	Gate to internal output		7.0		8.0		8.0		9.0		10.0		11.0		12.0	ns
t <sub>GOA</sub>	Gate to output		9.0		10.0		10.0		11.0		12.0		13.0		14.0	ns
<b>Input Register Delays:</b>																
t <sub>SIRS</sub>	Input register setup time using a synchronous clock	2.0		2.0		2.0		3.0		3.0		3.0		3.0		ns
t <sub>SIRA</sub>	Input register setup time using an asynchronous clock	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t <sub>HIRS</sub>	Input register hold time using a synchronous clock	3.0		3.0		3.0		4.0		4.0		4.0		4.0		ns
t <sub>HIRA</sub>	Input register hold time using an asynchronous clock	6.0		6.0		6.0		7.0		7.0		7.0		7.0		ns
<b>Input Latch Delays:</b>																
t <sub>SIL</sub>	Input latch setup time	2.0		2.0		2.0		3.0		3.0		3.0		3.0		ns
t <sub>HIL</sub>	Input latch hold time	6.0		6.0		6.0		7.0		7.0		7.0		7.0		ns
t <sub>PDILI</sub>	Transparent input latch		5.0		5.0		5.5		6.0		6.0		6.0		6.0	ns
<b>Output Delays:</b>																
t <sub>BUF</sub>	Output buffer delay		2.0		2.0		2.0		2.0		2.0		2.0		2.0	ns
t <sub>SLW</sub>	Slow slew rate delay		2.5		2.5		2.5		2.5		2.5		2.5		2.5	ns
t <sub>EA</sub>	Output enable time		7.5		7.5		9.5		10.0		12.0		15.0		20.0	ns
t <sub>ER</sub>	Output disable time		7.5		7.5		9.5		10.0		12.0		15.0		20.0	ns

**Select devices have been discontinued.  
See Ordering Information section for product status.**

## M5(LV) TIMING PARAMETERS OVER OPERATING RANGES<sup>1</sup> (CONTINUED)

	-5		-6		-7		-10		-12		-15		-20		Unit	
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
<b>Power Delays:</b>																
t <sub>PL1</sub>	Power level 1 delay (Note 2)		4.0 (5.0)		4.0		4.0 (5.0)		4.0 (5.0)		4.0 (5.0)		4.0 (5.0)		4.0 (5.0)	ns
t <sub>PL2</sub>	Power level 2 delay (Note 2)		6.0 (9.0)		6.0		6.0 (9.0)		6.0 (9.0)		6.0 (9.0)		6.0 (9.0)		6.0 (9.0)	ns
t <sub>PL3</sub>	Power level 3 delay (Note 2)		9.0 (17.5)		9.0		9.0 (17.5)		9.0 (17.5)		9.0 (17.5)		9.0 (17.5)		9.0 (17.5)	ns
<b>Additional Cluster Delay:</b>																
t <sub>PT</sub>	Product term cluster delay		0.3		0.3		0.3		0.3		0.3		0.3		0.3	ns
<b>Interconnect Delays:</b>																
t <sub>BLK</sub>	Block interconnect delay		1.5		1.5		1.5		2.0		2.0		2.0		2.0	ns
t <sub>SEG</sub>	Segment interconnect delay		4.5		4.5		5.0		6.0		6.0		6.0		6.0	ns
<b>Reset and Preset Delays:</b>																
t <sub>SRI</sub>	Asynchronous reset or preset to internal register output		6.0		8.0		8.0		10.0		12.0		14.0		16.0	ns
t <sub>SR</sub>	Asynchronous reset or preset to register output		8.0		10.0		10.0		12.0		14.0		16.0		18.0	ns
t <sub>SRR</sub>	Reset and set register recovery time	5.5		7.5		7.5		8.0		9.0		10.0		11.0		ns
t <sub>SRW</sub>	Asynchronous reset or preset width	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
<b>Clock Enable Delays:</b>																
t <sub>CES</sub>	Clock enable setup time	4.0		5.0		5.0		6.0		7.0		7.0		8.0		ns
t <sub>CEH</sub>	Clock enable hold time	3.0		4.0		4.0		5.0		6.0		6.0		7.0		ns
<b>Width:</b>																
t <sub>WLS</sub>	Global clock width low (Note 3)	2.5		3.0		3.0		4.0		5.0		6.0		6.0		ns
t <sub>WHS</sub>	Global clock width high (Note 3)	2.5		3.0		3.0		4.0		5.0		6.0		6.0		ns
t <sub>WLA</sub>	Product term clock width low	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>WHA</sub>	Product term clock width high	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>GWA</sub>	Gate width low (for low transparent) or high (for high transparent)	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns
t <sub>WIR</sub>	Input register clock width low or high	3.0		4.0		4.0		5.0		6.0		7.0		8.0		ns

Select devices have been discontinued.  
See Ordering Information section for product status.

## CAPACITANCE<sup>1</sup>

Parameter Symbol	Parameter Description	Test conditions		Typ	Unit
$C_{IN}$	I/CLK pin	$V_{IN} = 2.0\text{ V}$	$3.3\text{ V or }5\text{ V}, 25^\circ\text{ C}, 1\text{ MHz}$	12	pF
$C_{I/O}$	I/O pin	$V_{OUT} = 2.0\text{ V}$	$3.3\text{ V or }5\text{ V}, 25^\circ\text{ C}, 1\text{ MHz}$	10	pF

1. These parameters are not 100% tested, but are calculated at initial characterization and at any time the design is modified where these parameters may be affected.

## $I_{CC}$ vs. FREQUENCY

These curves represent the typical power consumption for a particular device at system frequency. The selected “typical” pattern is a 16-bit up-down counter. This pattern fills the device and exercises every macrocell. Maximum frequency shown uses internal feedback and a D-type register. Power/Speed are optimized to obtain the highest counter frequency and the lowest power. The highest frequency (LSBs) is placed in common PAL blocks, which are set to high power. The lowest frequency signals (MSBs) are placed in a common PAL block and set to lowest power. For a more detailed discussion about MACH 5 power consumption, refer to the application note entitled *MACH 5 Power* in the Application Notes section on the Lattice Data Book CD-ROM or Lattice web site.

## $I_{CC}$ CURVES AT HIGH /LOW POWER MODES

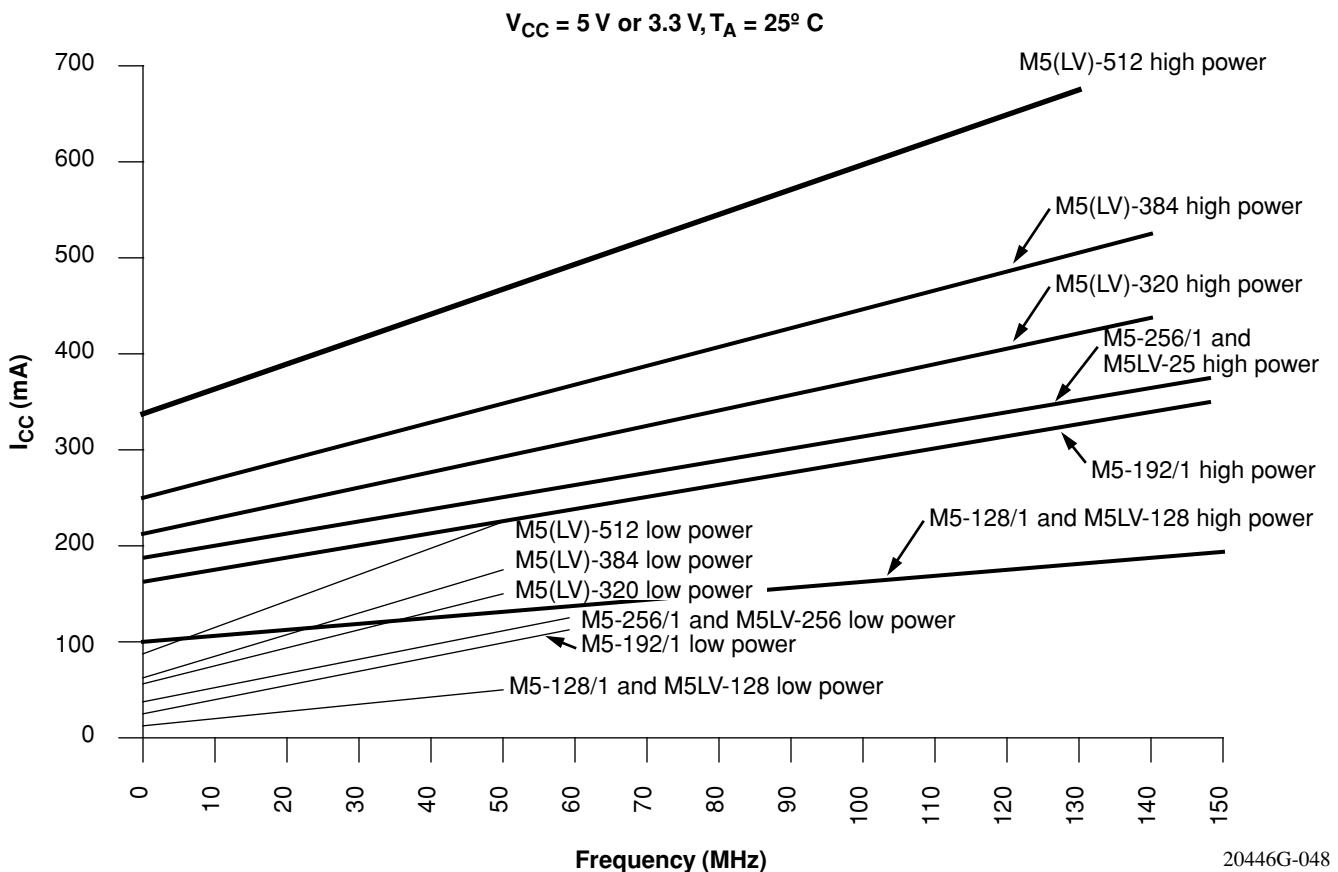
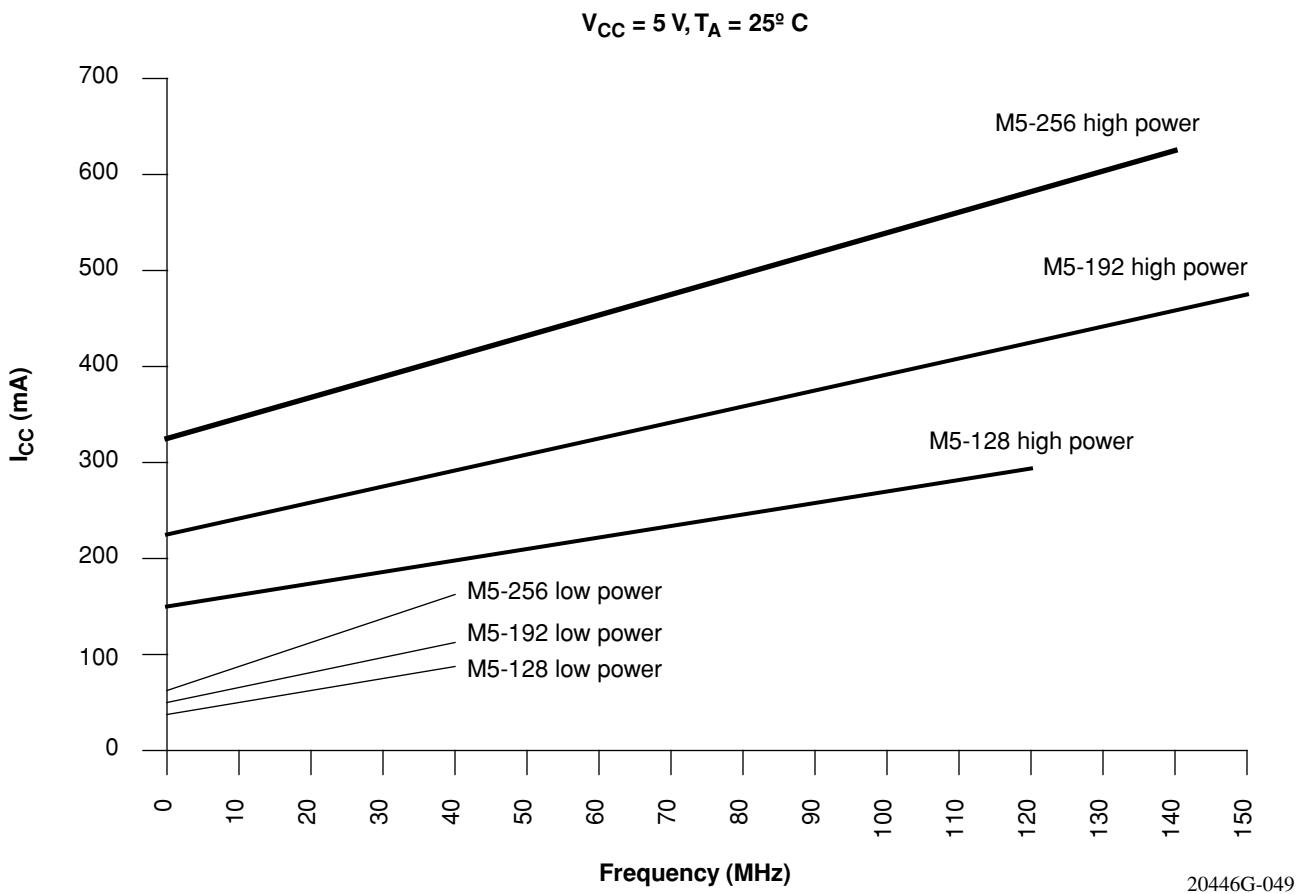


Figure 8.  $I_{CC}$  Curves at High/Low Power Modes

20446G-048



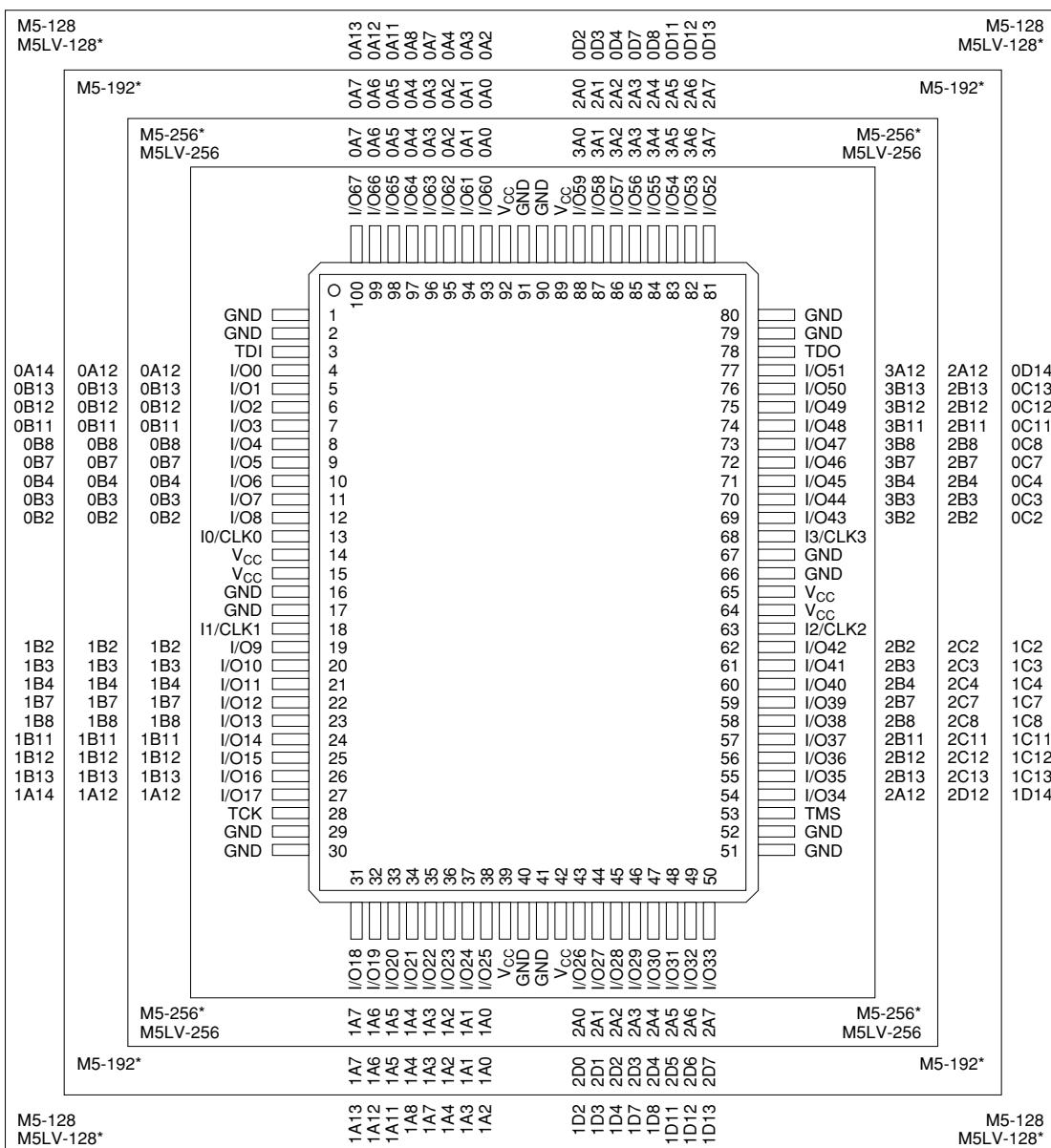
**Figure 9.  $I_{CC}$  Curves at High/Low Power Modes**

Select devices have been discontinued.  
See Ordering Information section for product status.

# 100-PIN PQFP CONNECTION DIAGRAM

## Top View

## **100-Pin PQFP (68 I/O)**

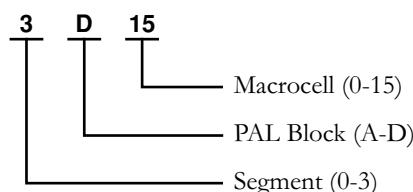


\*Package obsolete, contact factory.

20446G-016

## Pin Designations

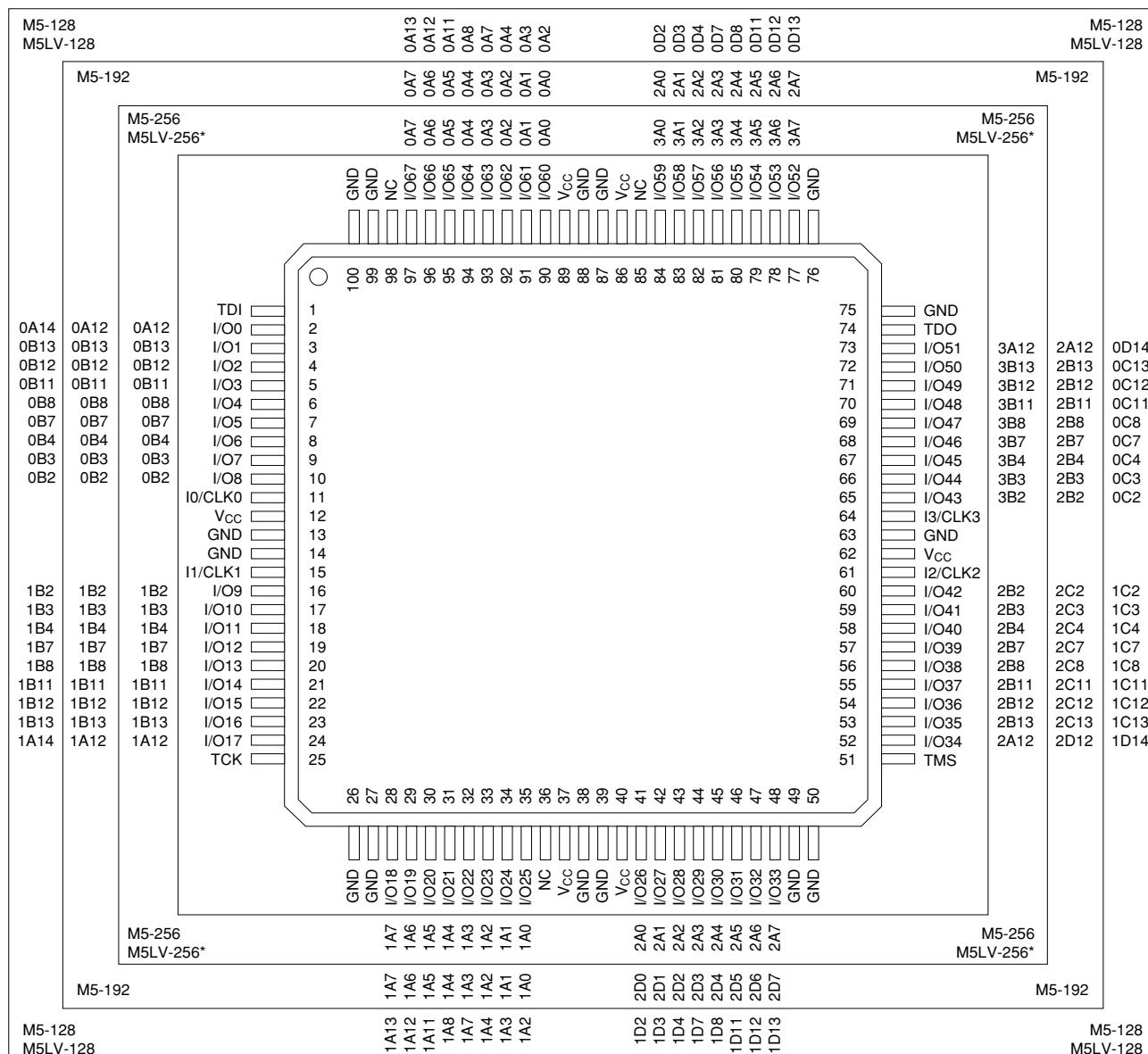
CLK	=	Clock		V <sub>CC</sub>	=	Supply Voltage
GND	=	Ground		TDI	=	Test Data In
I	=	Input		TCK	=	Test Clock
I/O	=	Input/Output		TMS	=	Test Mode Select
NC	=	No Connect		TDO	=	Test Data Out



## 100-PIN TQFP CONNECTION DIAGRAM – 68 I/O

### Top View

100-Pin TQFP (68 I/O)

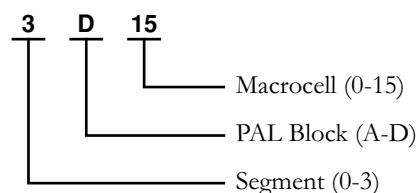


\*Package obsolete, contact factory.

20446G-017

### Pin Designations

CLK	= Clock	V <sub>CC</sub>	= Supply Voltage
GND	= Ground	TDI	= Test Data In
I	= Input	TCK	= Test Clock
I/O	= Input/Output	TMS	= Test Mode Select
NC	= No Connect	TDO	= Test Data Out



Select devices have been discontinued.  
See Ordering Information section for product status.

## 256-BALL BGA CONNECTION DIAGRAM — M5-320

### Bottom View (Macrocell Association)

256-Ball BGA

	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	
A	GND	0B2	GND	0B13	4A14	GND	4A8	4A4	GND	GND	GND	4B4	4B8	GND	4B14	3B13	GND	GND	GND	A	
B	GND	0A3	0B8	0B11	4A15	4A11	4A10	4A6	4A3	4A0	4B0	4B3	4B6	4B10	4B11	4B15	3B11	3B8	3B2	GND	B
C	0D15	0A8	V <sub>CC</sub>	0B3	0B4	0B12	4A13	4A9	4A5	4A1	4B1	4B5	4B9	4B13	3B12	3B4	3B3	V <sub>CC</sub>	3A3	3A11	C
D	0D13	0A11	0A2	V <sub>CC</sub>	V <sub>CC</sub>	0B7	V <sub>CC</sub>	4A12	4A7	4A2	4B2	4B7	4B12	V <sub>CC</sub>	3B7	V <sub>CC</sub>	3A2	3A8	3D15	D	
E	0D10	0A13	0A4	TDI												TDO	3A4	3A13	3D12	E	
F	GND	0D12	0A12	0A7												3A7	3A12	3D13	GND	F	
G	0D7	0D8	0D14	V <sub>CC</sub>												V <sub>CC</sub>	3D14	3D9	3D7	G	
H	GND	0D4	0D9	0D11												3D11	3D10	3D8	GND	H	
J	0D2	0D3	0D5	0D6												3D6	3D5	3D4	3D3	J	
K	GND	I/O/CLK0	0D0	0D1												3D1	3D0	I <sub>3</sub> /CLK3	3D2	K	
L	1D2	I <sub>1</sub> /CLK1	1D0	1D1												2D1	2D0	I <sub>2</sub> /CLK2	GND	L	
M	1D3	1D4	1D5	1D6												2D6	2D5	2D3	2D2	M	
N	GND	1D8	1D10	1D11												2D11	2D9	2D4	GND	N	
P	1D7	1D9	1D14	V <sub>CC</sub>												V <sub>CC</sub>	2D14	2D8	2D7	P	
R	GND	1D13	1A14	1A11												2A11	2A14	2D12	GND	R	
T	1D12	1A15	1A10	TCK												TMS	2A10	2A15	2D10	T	
U	1D15	1A12	1A8	V <sub>CC</sub>	V <sub>CC</sub>	1A4	V <sub>CC</sub>	1B3	1B8	1B13	2B13	2B8	2B3	V <sub>CC</sub>	2A4	V <sub>CC</sub>	2A8	2A13	2D13	U	
V	1A13	1A9	V <sub>CC</sub>	1A6	1A5	1A1	1B2	1B6	1B10	1B14	2B14	2B10	2B6	2B2	2A1	2A5	2A6	V <sub>CC</sub>	2A12	2D15	V
W	GND	1A7	1A3	1A2	1B0	1B4	1B5	1B9	1B12	1B15	2B15	2B12	2B9	2B5	2B4	2B0	2A2	2A3	2A9	GND	W
Y	GND	GND	GND	1A0	1B1	GND	1B7	1B11	GND	GND	2B11	2B7	GND	2B1	2A0	GND	2A7	GND	Y		
	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	

**Pin Designations**

- CLK = Clock
- GND = Ground
- I = Input
- I/O = Input/Output
- NC = No Connect
- V<sub>CC</sub> = Supply Voltage
- TDI = Test Data In
- TCK = Test Clock
- TMS = Test Mode Select
- TDO = Test Data Out

The diagram shows a grid of pins labeled A through Y. A bracket on the left side groups pins 4, D, and 15. Another bracket on the right side groups pins 1, 15, and 4. Labels indicate the association of these groups with Macrocell (0-15), PAL Block (A-D), and Segment (0-4).

**Select devices have been discontinued.**  
**See Ordering Information section for product status.**

## 352-BALL BGA CONNECTION DIAGRAM — M5-512, M5LV-512

Bottom View (I/O Pin-outs)

352-Ball BGA

A	NC	GND	NC	I/O51	GND	I/O73	I/O80	I/O87	GND	I/O101	NC	I/O114	GND	I/O128	I/O134	I/O142	GND	I/O156	I/O162	GND	NC	GND	NC	NC	A					
B	NC	GND	NC	I/O52	I/O68	I/O74	I/O81	I/O88	I/O95	I/O102	I/O107	I/O115	I/O122	I/O129	I/O135	I/O143	I/O150	I/O157	I/O163	I/O169	I/O176	I/O183	I/O188	GND	NC	NC	B			
C	GND	I/O11	TDI	I/O53	I/O69	I/O75	I/O82	I/O89	I/O96	I/O103	I/O108	I/O116	I/O123	I/O130	I/O136	I/O144	I/O151	I/O158	I/O160	I/O169	I/O170	I/O177	I/O184	NC	NC	NC	C			
D	I/O0	I/O12	I/O32	V <sub>CC</sub>	I/O70	I/O76	I/O83	I/O90	V <sub>CC</sub>	I/O104	I/O109	I/O117	V <sub>CC</sub>	I/O131	I/O137	I/O145	V <sub>CC</sub>	I/O159	I/O165	I/O171	I/O178	V <sub>CC</sub>	TDO	I/O205	I/O224	GND	D			
E	NC	I/O13	I/O33	I/O54																		I/O189	I/O206	I/O225	NC	NC	E			
F	GND	I/O14	I/O34	I/O55																		I/O190	I/O207	I/O226	I/O245		F			
G	I/O1	I/O15	I/O35	V <sub>CC</sub>																		I/O191	I/O208	I/O227	GND	G				
H	I/O2	I/O16	I/O36	I/O56																		V <sub>CC</sub>	I/O209	I/O228	I/O246		H			
J	GND	I/O17	I/O37	V <sub>CC</sub>																		I/O192	I/O210	I/O229	I/O247	J				
K	I/O3	I/O18	I/O38	I/O57																		V <sub>CC</sub>	I/O211	I/O230	GND	K				
L	I/O4	I/O19	I/O39	I/O58																		I/O193	I/O212	I/O231	I/O248	L				
M	I/O5	I/O20	I/O40	I/O59																		I/O194	I/O213	I/O232	I/O249	M				
N	GND	I/O21	I/OCLK0	V <sub>CC</sub>																	I/O195	I/O214	I/O233	I/OCLK3	N					
P	I/OCLK1	I/O22	I/O41	I/O60																		V <sub>CC</sub>	I/O215	I/O234	GND	P				
R	I/O6	I/O23	I/O42	I/O61																		I/O196	I/O216	I/O235	I/O250	R				
T	I/O7	I/O24	I/O43	I/O62																		I/O197	I/O216	I/O236	I/O251	T				
U	GND	I/O25	I/O44	V <sub>CC</sub>																	I/O198	I/O217	I/O237	I/O252	U					
V	I/O8	I/O26	I/O45	I/O63																		V <sub>CC</sub>	I/O218	I/O238	GND	V				
W	I/O9	I/O27	I/O46	V <sub>CC</sub>																	I/O199	I/O219	I/O239	I/O253	W					
Y	GND	I/O28	I/O47	I/O64																		V <sub>CC</sub>	I/O220	I/O240	I/O254	Y				
AA	I/O10	I/O29	I/O48	I/O65																		I/O200	I/O221	I/O241	GND	AA				
AB	NC	NC	GND	NC	GND	NC	GND	NC	GND	NC	GND	NC	GND	I/O100	GND	I/O113	I/O121	I/O127	GND	I/O141	I/O149	I/O155	GND	I/O175	I/O182	GND	I/O204	NC	NC	AB
AC	GND	I/O31	I/O50	TCK	V <sub>CC</sub>	I/O77	I/O84	I/O91	I/O97	V <sub>CC</sub>	I/O110	I/O118	I/O124	V <sub>CC</sub>	I/O138	I/O146	I/O152	V <sub>CC</sub>	I/O166	I/O172	I/O179	I/O185	V <sub>CC</sub>	I/O223	I/O243	I/O255	AC			
AD	NC	NC	NC	NC	I/O71	I/O78	I/O85	I/O92	I/O98	I/O105	I/O111	I/O119	I/O125	I/O132	I/O139	I/O147	I/O153	I/O160	I/O167	I/O173	I/O180	I/O186	I/O202	TMS	I/O244	GND	AD			
AE	NC	NC	GND	I/O67	I/O72	I/O79	I/O86	I/O93	I/O99	I/O106	I/O112	I/O120	I/O126	I/O133	I/O140	I/O154	I/O161	I/O168	I/O174	I/O181	I/O187	I/O191	I/O197	I/O203	NC	GND	NC	AE		
AF	NC	NC	GND	NC	GND	NC	GND	NC	GND	I/O104	I/O108	I/O113	I/O121	I/O127	GND	I/O141	I/O149	I/O155	GND	I/O175	I/O182	GND	I/O204	NC	GND	NC	AF			
20446G-030																														
26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1					

### Pin Designations

- CLK = Clock
- GND = Ground
- I = Input
- I/O = Input/Output
- NC = No Connect
- V<sub>CC</sub> = Supply Voltage
- TDI = Test Data In
- TCK = Test Clock
- TMS = Test Mode Select
- TDO = Test Data Out

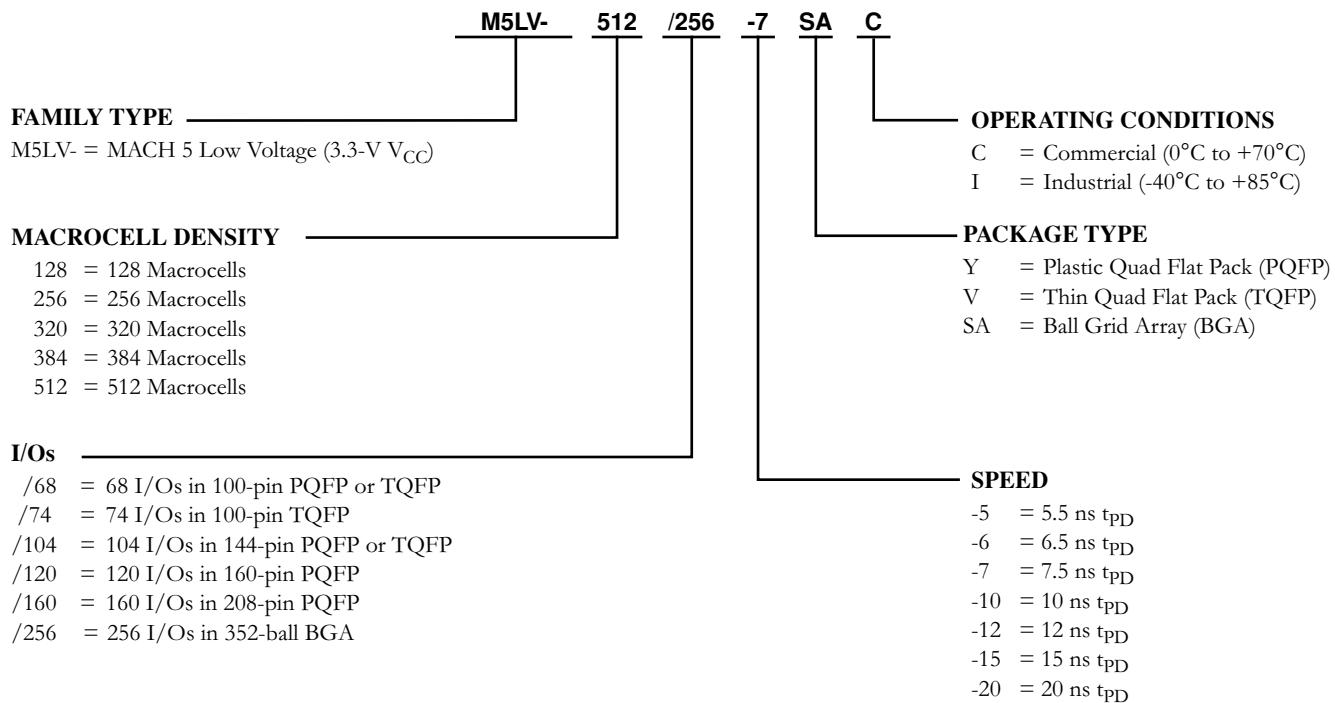
Select devices have been discontinued.

See Ordering Information section for product status.

Select devices have been discontinued.  
See Ordering Information section for product status.

## 3.3V M5LV ORDERING INFORMATION<sup>1</sup>

Lattice standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



**Note:**

1. See below for valid device/package combinations.

Valid Combinations		
M5LV-128/68		VC, VI
M5LV-128/74		VC, VI
M5LV-128/104	Commercial:	VC, VI
M5LV-128/120	-5, -7, -10, -12	YC, YI
M5LV-256/68		YC, YI
M5LV-256/74	Industrial:	VC, VI
M5LV-256/104	-7, -10, -12, -15	VC, VI
M5LV-256/120		YC, YI
M5LV-256/160		YC, YI

### Device Marking

Actual device marking differs from the ordering part number (OPN). All MACH devices are dual-marked with both Commercial and Industrial grades. The Industrial grade is slower, i.e., M5LV-512/256-7AC-10AI.

Valid Combinations		
M5LV-320/120		YC, YI
M5LV-320/160	Commercial:	YC, YI
M5LV-384/120	-6, -7, -10, -12, -15	YC, YI
M5LV-384/160		YC, YI
M5LV-512/120	Industrial:	YC, YI
M5LV-512/160	-10, -12, -15, -20	YC, YI
M5LV-512/256		SAC, SAI

### Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Lattice sales office to confirm availability of specific valid combinations and to check on newly released combinations.